Universität Bremen - Computer Architecture

Test Case Generation from Mutants using Model Checking Techniques

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Test Case Generation with Mutation Testing

How does mutation testing work?

- 1. Seed artificial faults.
- 2. Write test cases that catch the faults.
- 3. Collect the test cases in a database.





The Problem

But: writing test cases that catch the faults is tedious [GSZ09]!



A test case has to satisfy three conditions to catch a fault [DO91].

- 1. Reach the location of the fault.
- 2. Infect the program state when the fault is executed.
- 3. Propagate the infected state to an output.



Help from Formal Methods?

Bounded Model Checking [BCCZ99]

- Given: a state-transition graph (model) and a safety property
- Search for a counterexamples of finite length k

Satisfiability Modulo Theories (SMT) [BHvMW09]

- Efficient decision procedure for constraint satisfaction
- Selects a specific background theory
- SMT solvers are implemented on top of SAT solvers
- Solving the constraints is NP-complete









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- Solve $f_k \wedge f'_k \wedge (i = i') \wedge (o \neq o')$
- A satisfying assignments is a test cases.



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- The mutant is equivalent with respect to k if the formula is unsatisfiable.



Functional equivalence checking with respect to a bounded model is decidable!

Use BMC to encode all paths up to length k

- Encode the program into formula f_k
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- 1. Seed faults into the compiler's intermediate representation
 - Independent from the front-end's language
 - Eases later translations!





2. Construct a meta-mutant [UOH93] containing all faults





3. Unroll loops k-times and encode the program as logic formula



```
 \begin{array}{l} sum = 0; \\ for ( int u = 1; u < 3; ++u ) \{ \\ sum += u; \\ \} \end{array}
```

1. Consider a fragment of a C program.



2. Transform the C code into intermediate code.



Seed faults and construct a meta-mutant.





(Redraw the graph with less detail ...)





4. Unroll the control flow graph (k = 1).





Unroll again (k = 2).





Unroll again (k = 3).



5. Transform the unrolled meta-mutant into SSA form.





6. Encode the meta-mutant into a logic formula.

Test Case Generation

- Given: the meta-mutant M and an unrolling bound k
- ► The meta-mutant is k-times unrolled and encoded twice into bitvector formulae f_k and f'_k
- We constrain the fault id id = 0 in f_k but keep the fault id in f'_k unconstrained
- We assert equal input variables and different output variables
- An SMT-solver incrementally solves $f_k \wedge f'_k$
 - We collect a satisfying assignment as test case, constrain the fault id, and re-solve the formula.
 - When the formula becomes unsatisfiable, all undetect faults are proved to be equivalent.



Experimental Results

Table: Results of the test case generation with Boolector

Name	Instr. (Program)	Instr. (Meta- Mutant)	Faults	Test Cases	s Time [s]
min	24	71	17	16	0.48
isl	20	80	19	18	0.14
fmin3	40	137	33	23	7.49
fmin5	58	203	49	37	34.38
fmin10	103	368	89	72	213.65
mid	52	194	46	43	6.82
tri	116	819	206	196	246.80



Experimental Results



Figure: Detected faults for tri over time.



Experimental Results



Figure: Test case generation for benchmark tri over time.



Conclusions & Future Works

- Our approach is complete with respect to the unrolling bound
 - 1. It detects all non-equivalent faults in the unrolled model and
 - 2. proves equivalence with respect to the bound of all undetected faults
- We have not considered simulation, which improves runtime
- Under development:
 - Support for pointers and arrays
 - Case-Study



Thank you for your attention! Questions?

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